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# Technical Compliance

No. ACS-E19254

The following product has been tested by us with the listed standards and found in compliance with the council EMC directive 2014/30/EU. It is demonstrative for the compliance with this EMC Directive.

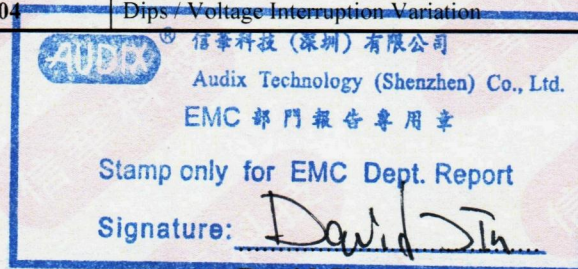
**Applicant** : TPV Electronics (FuJian) Co., Ltd.  
 Rongqiao Economic and Technological Development  
 Zone, Fuqing City, Fujian Province, P.R. China

**Product** : LCD Monitor

**Model No.** : NSD-4301Q\*(\* = 0-9, A-Z, a-z, +, -, /, \ or blank)

## Test Standards :

EN 55032: 2012+AC: 2013 (Class A) CISPR 32: 2012 AS/NZS CISPR:2015	Electromagnetic compatibility of multimedia equipment - Emission requirements	
EN 61000-3-2: 2014	Electromagnetic Compatibility(EMC) Part 3-2:Limits-Limits for harmonic current emissions(equipment input current $\leq 16A$ per phase)	
EN 61000-3-3: 2013	Electromagnetic Compatibility(EMC) Part 3-3:Limits-Limitation of voltage changes, voltage fluctuations and flicker in public low-voltage supply systems, for equipment with rated current $\leq 16A$ per phase and not subject to conditional connection	
EN 55020: 2007+A11: 2011	Sound and television broadcast receivers and associated equipment-Immunity Characteristics-Limits and methods of measurement	
EN 55024: 2010 EN 55024: 2010+A1:2015	Information technology equipment-Immunity characteristics limits and methods of measurement	
	IEC 61000-4-2: 2008	Electrostatic Discharge
	IEC 61000-4-3: 2010	RF Field Strength Susceptibility
	IEC 61000-4-4: 2012	Electrical Fast Transients
	IEC 61000-4-5: 2014	Surge
	IEC 61000-4-6: 2013	Conducted Susceptibility
	IEC 61000-4-8: 2009	Magnetic Field Immunity
	IEC 61000-4-11: 2004	Dips / Voltage Interruption Variation



David Jin  
 Manager

Date: Sep.30, 2019

The technical compliance is based on a single evaluation of one sample of above mentioned product. It does not imply an assessment of the whole production and does not permit the use of the test lab. logo.